Integrated Circuit Systems, Inc.

ICS8344

LOW SKEW, 1-TO-24 DIFFERENTIAL-TO-LVCMOS FANOUT BUFFER

GENERAL DESCRIPTION

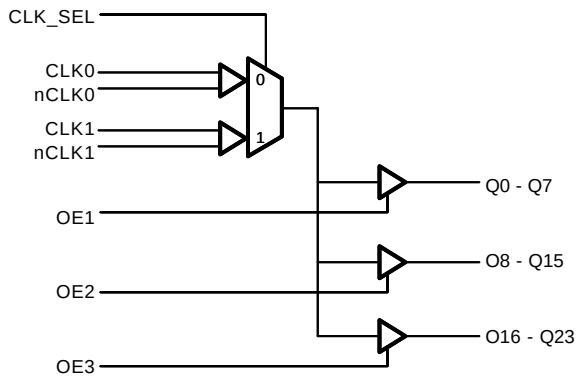
The ICS8344 is a low voltage, low skew fanout buffer and a member of the HiPerClockS™ family of High Performance Clock Solutions from ICS. The ICS8344 is designed to translate any differential signal levels to LVCMOS levels. The low impedance LVCMOS outputs are designed to drive 50Ω series or parallel terminated transmission lines. The effective fanout can be increased to 48 by utilizing the ability of the outputs to drive two series terminated lines. Redundant clock applications can make use of the dual clock input. The dual clock inputs also facilitate board level testing. ICS8344 is characterized at full 3.3V, full 2.5V and mixed 3.3V input and 2.5V output operating supply modes.

Guaranteed output and part-to-part skew characteristics make the ICS8344 ideal for those clock distribution applications demanding well defined performance and repeatability.

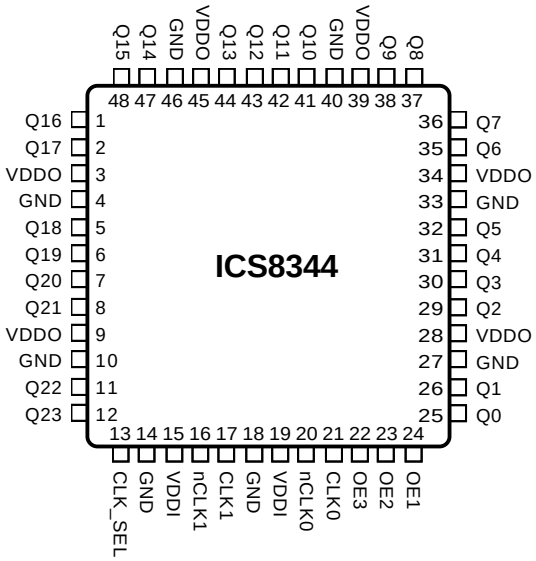
FEATURES

- 24 LVCMOS outputs, 7Ω typical output impedance
- Output frequency up to 167MHz
- 275ps output skew, 600ps part to part skew
- Translates any differential input signal (PECL, HSTL, LVDS) to LVCMOS without external bias networks
- Translates any single-ended input signal to LVCMOS with resistor bias on nCLK input
- Translates and inverts any single-ended input signal to LVCMOS with resistor bias on CLK input
- Multiple differential clock input pairs for redundant clock applications
- LVCMOS control inputs
- Multiple output enable pins for disabling unused outputs in reduced fanout applications
- 3.3V, 2.5V or mixed 3.3V, 2.5V operating supply modes
- 48 lead low-profile QFP(LQFP), 7mm x 7mm x 1.4mm package body, 0.5mm package lead pitch
- 0°C to 70°C ambient operating temperature
- Industrial temperature versions available upon request

BLOCK DIAGRAM



PIN ASSIGNMENT



48-Lead LQFP
Y Package
Top View

TABLE 1. PIN DESCRIPTIONS

Number	Name	Type		Description
1, 2, 5, 6 7, 8, 11, 12	Q16, Q17, Q18, Q19 Q20, Q21, Q22, Q23	Output		Q15 thru Q23 outputs. 7Ω typical output impedance.
3, 9, 28, 34, 39, 45	VDDO	Power		Output power supply. Connect 3.3V or 2.5V.
4, 10, 14,18, 27, 33, 40, 46	GND	Power		Power supply ground. Connect to ground.
13	CLK_SEL	Input	Pulldown	Clock select input. Selects between CLK0, nCLK0 and CLK1, nCLK1 as the differential pair that controls the output.
15, 19	VDDI	Power		Input power supply. Connect 3.3V or 2.5V.
16	nCLK1	Input	Pullup	Inverting input of secondary differential clock input pair.
17	CLK1	Input	Pulldown	Non-inverting input of secondary differential clock input pair.
20	nCLK0	Input	Pullup	Inverting input of primary differential clock input pair.
21	CLK0	Input	Pulldown	Non-inverting input of primary differential clock input pair.
22	OE3	Input	Pullup	Output enable. Controls enabling and disabling of outputs Q16 thru Q23.
23	OE2	Input	Pullup	Output enable. Controls enabling and disabling of outputs Q8 thru Q15.
24	OE1	Input	Pullup	Output enable. Controls enabling and disabling of outputs Q0 thru Q7.
25, 26, 29, 30 31, 32, 35, 36	Q0, Q1, Q2, Q3 Q4, Q5, Q6, Q7	Output		Q0 thru Q7 outputs. 7Ω typical output impedance.
37, 38, 41, 42 43, 44, 47, 48	Q8, Q9, Q10, Q11 Q12, Q13, Q14, Q15	Output		Q8 thru Q15 outputs. 7Ω typical output impedance.

TABLE 2. PIN CHARACTERISTICS

Symbol	Parameter		Test Conditions	Minimum	Typical	Maximum	Units
CIN	Input Capacitance	CLK0, nCLK0, CLK1, nCLK1					pF
		CLK_SEL, OE1, OE2, OE3					pF
CPD	Power Dissipation Capacitance (per output)		VDDI, VDDO = 3.465V				pF
			VDDI = 3.465V, VDDO = 2.625V				pF
			VDDI, VDDO = 2.625V				pF
RPULLUP	Input Pullup Resistor				51		KΩ
RPULLDOWN	Input Pulldown Resistor				51		KΩ
ROUT	Output Impedance				7		Ω

TABLE 3A. OUTPUT ENABLE FUNCTION TABLE

Bank 1		Bank 2		Bank 3	
Input	Output	Input	Output	Input	Output
OE1	Q0-Q7	OE2	Q8-Q15	OE3	Q16-Q23
0	Hi-Z	0	Hi-Z	0	Hi-Z
1	Active	1	Active	1	Active

TABLE 3B. CLOCK SELECT FUNCTION TABLE

Control Input	Clock	
CLK_SEL	CLK0, nCLK0	CLK1, nCLK1
0	Selected	De-selected
1	De-selected	Selected

TABLE 3C. CLOCK INPUTS FUNCTION TABLE

Inputs			Outputs	Input to Output Mode	Polarity
OE1, OE2, OE3	CLK	nCLK	Q0 thru Q23		
1	0	1	LOW	Differential to Single Ended	Non Inverting
1	1	0	HIGH	Differential to Single Ended	Non Inverting
1	0	Biased; NOTE 1	LOW	Single Ended to Differential	Non Inverting
1	1	Biased; NOTE 1	HIGH	Single Ended to Differential	Non Inverting
1	Biased; NOTE 1	0	HIGH	Single Ended to Differential	Inverting
1	Biased; NOTE 1	1	LOW	Single Ended to Differential	Inverting

NOTE 1: Single ended input use requires that one of the differential inputs be biased. The voltage at the biased input sets the switch point for the single ended input. For LVCMOS input levels the recommended input bias network is a resistor to VDDI, a resistor of equal value to ground and a 0.1µF capacitor from the input to ground. The resulting switch point is VDDI/2.

ABSOLUTE MAXIMUM RATINGS

Supply Voltage	4.6V
Inputs	-0.5V to VDD + 0.5V
Outputs	-0.5V to VDDO + 0.5V
Ambient Operating Temperature	0°C to 70°C
Storage Temperature	-65°C to 150°C

Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These ratings are stress specifications only and functional operation of product at these condition or any conditions beyond those listed in the *DC Characteristics* or *AC Characteristics* is not implied. Exposure to absolute maximum rating conditions for extended periods may affect product reliability.

TABLE 4A. POWER SUPPLY DC CHARACTERISTICS, VDDI = VDDO = 3.3V±5%, TA = 0°C TO 70°C

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
VDDI	Input Power Supply Voltage		3.135	3.3	3.465	V
VDDO	Output Power Supply Voltage		2.375	2.5	2.625	V
IDDI	Quiescent Power Supply Current	VDDI = VIH = 3.465V VIL = 0V			120	mA

TABLE 4B. DIFFERENTIAL DC CHARACTERISTICS, VDDI = VDDO = 3.3V±5%, TA = 0°C TO 70°C

Symbol	Parameter		Test Conditions	Minimum	Typical	Maximum	Units
IIH	Input High Current	nCLK0, nCLK1				5	µA
		CLK0, CLK1				150	µA
IIL	Input Low Current	nCLK0, nCLK1		-150			µA
		CLK0, CLK1		-5			µA

NOTE: For CLKx, nCLKx input levels, see VPP and VCMR in AC Characteristics table.

TABLE 4C. LVCMOS DC CHARACTERISTICS, VDDI = VDDO = 3.3V±5%, TA = 0°C TO 70°C

Symbol	Parameter		Test Conditions	Minimum	Typical	Maximum	Units
VIH	Input High Voltage	CLK_SEL, OE1, OE2, OE3	VDDI = 3.465V	2		3.8	V
VIL	Input Low Voltage	CLK_SEL, OE1, OE2, OE3	VDDI = 3.135V	-0.3		0.8	V
IIH	Input High Current	OE1, OE2, OE3	VDDI = VIN = 3.465V			5	µA
		CLK_SEL	VDDI = VIN = 3.465V			150	µA
IIL	Input Low Current	OE1, OE2, OE3	VDDI = 3.465, VIN = 0V	-150			µA
		CLK_SEL	VDDI = 3.465, VIN = 0	-5			µA
VOH	Output High Voltage		VDDI = VDDO = 3.135V IOH = -36mA	2.6			V
VOL	Output Low Voltage		VDDI = VDDO = 3.135V IOL = 36mA			0.6	V

TABLE 5A. AC ELECTRICAL CHARACTERISTICS, VDDI = VDDO = 3.3V±5%, TA = 0°C TO 70°C

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
fMAX	Maximum Input Frequency				167	MHz
VPP	Peak-to-Peak Input Voltage	f = 167MHz	0.3		1.3	V
VCMR	Common Mode Input Voltage	f = 167MHz	0.9		2	V
tpLH	Propagation Delay, Low-to-High	0MHz ≤ f ≤ 167MHz	2.6		4.3	ns
tpHL	Propagation Delay, High-to-Low	0MHz ≤ f ≤ 167MHz	2.4		4.3	ns
tsk(b)	Bank Skew; NOTE 2	Measured on the rising edge of VDDO/2			150	ps
tsk(o)	Output Skew; NOTE 3	Measured on the rising edge of VDDO/2			275	ps
tsk(pp)	Part-to-Part Skew; NOTE 4	Measured on the rising edge of VDDO/2			600	ps
tR	Output Rise Time; NOTE 5	30% to 70%	200		1000	ps
tF	Output Fall Time; NOTE 5	30% to 70%	200		1000	ps
tPW	Output Pulse Width	0MHz ≤ f ≤ 167MHz	tCYCLE/2- - 0.65	tCYCLE/2	tCYCLE/2 + 0.65	ns
		f = 167MHz	2.35	2.5	3.65	ns
tEN	Output Enable Time; NOTE 5	f = 66.7MHz			5	ns
tDIS	Output Disable TIme; NOTE 5	f = 66.7MHz			4	ns

NOTE 1: All parameters measured at 167MHz and VPPmin unless noted otherwise.
All outputs terminated with 50Ω to VDDO/2.
NOTE 2: Defined as skew within a bank of outputs at the same voltages and with equal load conditions.
NOTE 3: Defined as skew across banks of outputs at the same supply voltages and with equal load conditions.
NOTE 4: Defined as the skew at different outputs on different devices operating at the same supply voltages with equal load conditions.
NOTE 5: These parameters are guaranteed by characterization. Not tested in production.

TABLE 4D. POWER SUPPLY DC CHARACTERISTICS, VDDI = 3.3V±5%, VDDO = 2.5V±5%, T_A = 0°C TO 70°C

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
VDDI	Input Power Supply Voltage		3.135	3.3	3.465	V
VDDO	Output Power Supply Voltage		2.375	2.5	2.625	V
IDDI	Quiescent Power Supply Current	VDDI = VIH = 3.465V VIL = 0V			120	mA

TABLE 4E. DIFFERENTIAL DC CHARACTERISTICS, VDDI = 3.3V±5%, VDDO = 2.5V±5%, T_A = 0°C TO 70°C

Symbol	Parameter		Test Conditions	Minimum	Typical	Maximum	Units
IIH	Input High Current	nCLK0, nCLK1				5	µA
		CLK0, CLK1				150	µA
IIL	Input Low Current	nCLK0, nCLK1		-150			µA
		CLK0, CLK1		-5			µA

NOTE: For CLKx, nCLKx input levels, see VPP and VCMR in AC Characteristics table.

TABLE 4F. LVCMOS DC CHARACTERISTICS, VDDI = 3.3V±5%, VDDO = 2.5V±5%, T_A = 0°C TO 70°C

Symbol	Parameter		Test Conditions	Minimum	Typical	Maximum	Units
VIH	Input High Voltage	CLK_SEL, OE1, OE2, OE3	VDDI = 3.465V	2		3.8	V
VIL	Input Low Voltage	CLK_SEL, OE1, OE2, OE3	VDDI = 3.465V	-0.3		.8	V
IIH	Input High Current	OE1, OE2, OE3	VDDI = VIN = 3.465V			5	µA
		CLK_SEL	VDDI = VIN = 3.465V			150	µA
IIL	Input Low Current	OE1, OE2, OE3	VDDI = 3.465, VIN = 0V	-150			µA
		CLK_SEL	VDDI = 3.465, VIN = 0	-5			µA
VOH	Output High Voltage		VDDI = 3.135V, VDDO = 2.375V IOH = -36mA	1.8			V
VOL	Output Low Voltage		VDDI = 3.135V, VDDO = 2.365V IOL = 27mA			0.63	V

TABLE 5B. AC ELECTRICAL CHARACTERISTICS, VDDI = 3.3V±5%, VDDO = 2.5V±5%, T_A = 0°C TO 70°C

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
fMAX	Maximum Input Frequency				167	MHz
VPP	Peak-to-Peak Input Voltage	f = 167MHz	0.3		1.3	V
VCMR	Common Mode Input Voltage	f = 167MHz	0.9		2	V
tpLH	Propagation Delay, Low-to-High	0MHz ≤ f ≤ 167MHz	2.6		4.5	ns
tpHL	Propagation Delay, High-to-Low	0MHz ≤ f ≤ 167MHz	2.6		4.2	ns
tsk(b)	Bank Skew; NOTE 2	Measured on the rising edge of VDDO/2			150	ps
tsk(o)	Output Skew; NOTE 3	Measured on the rising edge of VDDO/2			275	ps
tsk(pp)	Part-to-Part Skew; NOTE 4	Measured on the rising edge of VDDO/2			600	ps
tR	Output Rise Time; NOTE 5	30% to 70%	300		1700	ps
tF	Output Fall Time; NOTE 5	30% to 70%	300		1400	ps
tPW	Output Pulse Width	0MHz ≤ f ≤ 167MHz	tCYCLE/2 - 0.65	tCYCLE/2	tCYCLE/2 + 0.65	ns
		f = 167MHz	2.35		3.65	ns
tEN	Output Enable Time; NOTE 5	f = 66.7MHz			6	ns
tDIS	Output Disable TIme; NOTE 5	f = 66.7MHz			6	ns

NOTE 1: All parameters measured at 167MHz and VPPmin unless noted otherwise.
All outputs terminated with 50Ω to VDDO/2.
NOTE 2: Defined as skew within a bank of outputs at the same voltages and with equal load conditions.
NOTE 3: Defined as skew across banks of outputs at the same supply voltages and with equal load conditions.
NOTE 4: Defined as the skew at different outputs on different devices operating at the same supply voltages with equal load conditions.
NOTE 5: These parameters are guaranteed by characterization. Not tested in production.

TABLE 4G. POWER SUPPLY DC CHARACTERISTICS, VDDI = VDDO = 2.5V±5%, T_A = 0°C TO 70°C

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
VDDI	Input Power Supply Voltage		2.375	2.5	2.625	V
VDDO	Output Power Supply Voltage		2.375	2.5	2.625	V
IDDI	Quiescent Power Supply Current	VDDI = VIH = 3.465V VIL = 0V			120	mA

TABLE 4H. DIFFERENTIAL DC CHARACTERISTICS, VDDI = VDDO = 2.5V±5%, T_A = 0°C TO 70°C

Symbol	Parameter		Test Conditions	Minimum	Typical	Maximum	Units
IIH	Input High Current	nCLK0, nCLK1				5	µA
		CLK0, CLK1				150	µA
IIL	Input Low Current	nCLK0, nCLK1		-150			µA
		CLK0, CLK1		-5			µA

NOTE: For CLKx, nCLKx input levels, see VPP and VCMR in AC Characteristics table.

TABLE 4I. LVCMOS DC CHARACTERISTICS, VDDI = VDDO = 2.5V±5%, T_A = 0°C TO 70°C

Symbol	Parameter		Test Conditions	Minimum	Typical	Maximum	Units
VIH	Input High Voltage	CLK_SEL, OE1, OE2, OE3	VDDI = 2.625V	2		2.9	V
VIL	Input Low Voltage	CLK_SEL, OE1, OE2, OE3	VDDI = 2.375V	-0.3		0.8	V
IIH	Input High Current	OE1, OE2, OE3	VDDI = VIN = 2.625V			5	µA
		CLK_SEL	VDDI = VIN = 2.625V			150	µA
IIL	Input Low Current	OE1, OE2, OE3	VDDI = 2.625, VIN = 0V	-150			µA
		CLK_SEL	VDDI = 2.625, VIN = 0	-5			µA
VOH	Output High Voltage		VDDI = VDDO = 2.375V IOH = -27mA	1.77			V
VOL	Output Low Voltage		VDDI = VDDO = 2.375V IOL = 27mA			0.6	V

TABLE 5C. AC ELECTRICAL CHARACTERISTICS, VDDI = VDDO = 2.5V±5%, T_A = 0°C TO 70°C

Symbol	Parameter	Test Conditions	Minimum	Typical	Maximum	Units
fMAX	Maximum Input Frequency				167	MHz
VPP	Peak-to-Peak Input Voltage	f = 167MHz	0.3		1.3	V
VCMR	Common Mode Input Voltage	f = 167MHz	0.9		2	V
tpLH	Propagation Delay, Low-to-High	0MHz ≤ f ≤ 167MHz	2.7		4.3	ns
tpHL	Propagation Delay, High-to-Low	0MHz ≤ f ≤ 167MHz	2.7		4.3	ns
tsk(b)	Bank Skew; NOTE 2	Measured on the rising edge of VDDO/2			150	ps
tsk(o)	Output Skew; NOTE 3	Measured on the rising edge of VDDO/2			275	ps
tsk(pp)	Part-to-Part Skew; NOTE 4	Measured on the rising edge of VDDO/2			600	ps
tR	Output Rise Time; NOTE 5	30% to 70%	300		1700	ps
tF	Output Fall Time; NOTE 5	30% to 70%	300		1400	ps
tPW	Output Pulse Width	0MHz ≤ f ≤ 167MHz	tCYCLE/2 - 0.65	tCYCLE/2	tCYCLE/2 + 0.65	ns
		f = 167MHz	2.35		3.65	ns
tEN	Output Enable Time; NOTE 5	f = 66.7MHz			6	ns
tDIS	Output Disable TIme; NOTE 5	f = 66.7MHz			6	ns

NOTE 1: All parameters measured at 167MHz and VPPmin unless noted otherwise.
All outputs terminated with 50 Ω to VDDO/2.
NOTE 2: Defined as skew within a bank of outputs at the same voltages and with equal load conditions.
NOTE 3: Defined as skew across banks of outputs at the same supply voltages and with equal load conditions.
NOTE 4: Defined as the skew at different outputs on different devices operating at the same supply voltages with equal load conditions.
NOTE 5: These parameters are guaranteed by characterization. Not tested in production.

FIGURE 1A, 1B, 1C - INPUT CLOCK WAVEFORMS

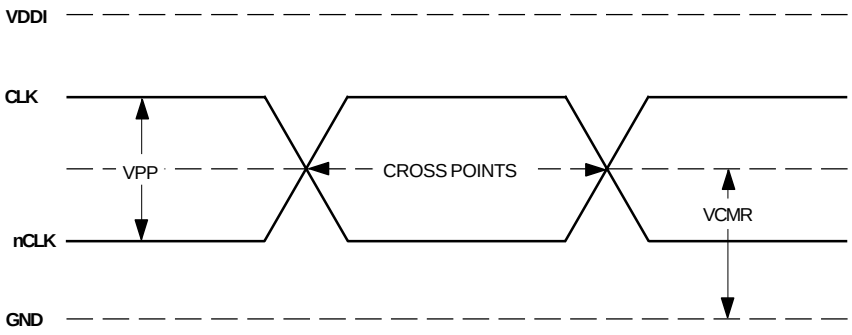


FIGURE 1A - LVDS, HSTL DIFFERENTIAL INPUT LEVELS

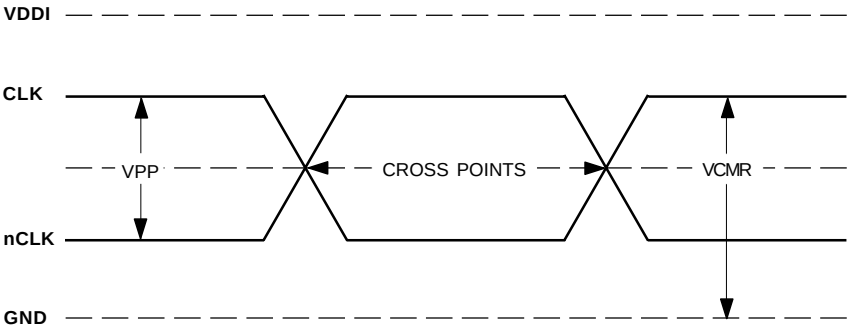


FIGURE 1B - LVPECL DIFFERENTIAL INPUT LEVEL

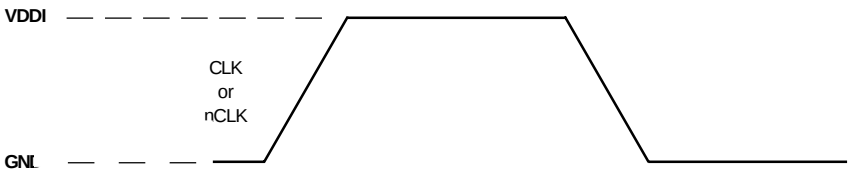


FIGURE 1C- LVCMOS AND LVTTL SINGLE ENDED INPUT LEVEL

FIGURE 2A, 2B - TIMING WAVEFORMS

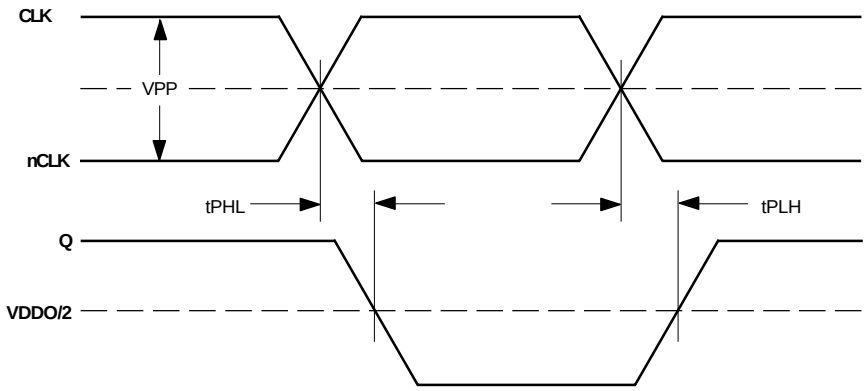


FIGURE 2A - PROPAGATION DELAYS

fin = 167MHz, Vpp = 300mV, tr = tf = 200ps

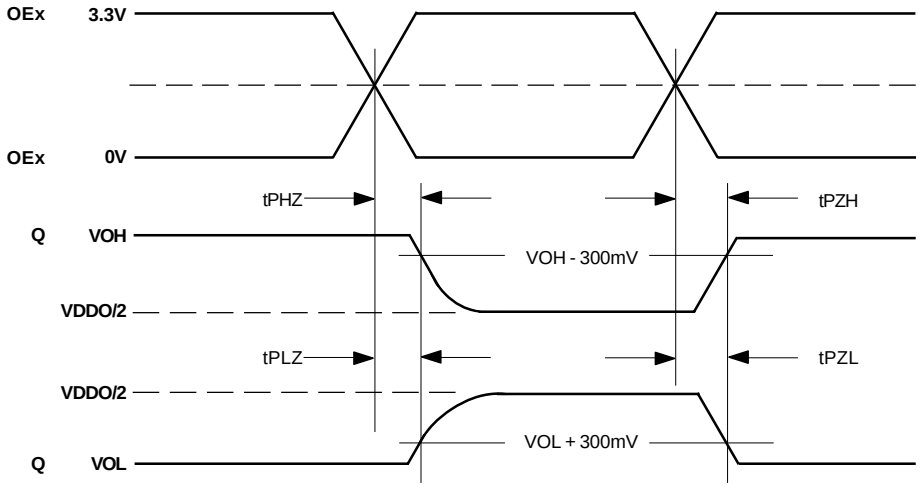


FIGURE 2B - DISABLE AND ENABLE TIMES

fin = 10MHz, Vamp = 3.3V, tr = tf = 600ps

FIGURE 3A, 3B- SKEW DEFINITIONS & WAVEFORMS

Bank Skew - Skew between outputs within a bank. Outputs operating at the same temperature, supply voltages and with equal load conditions.

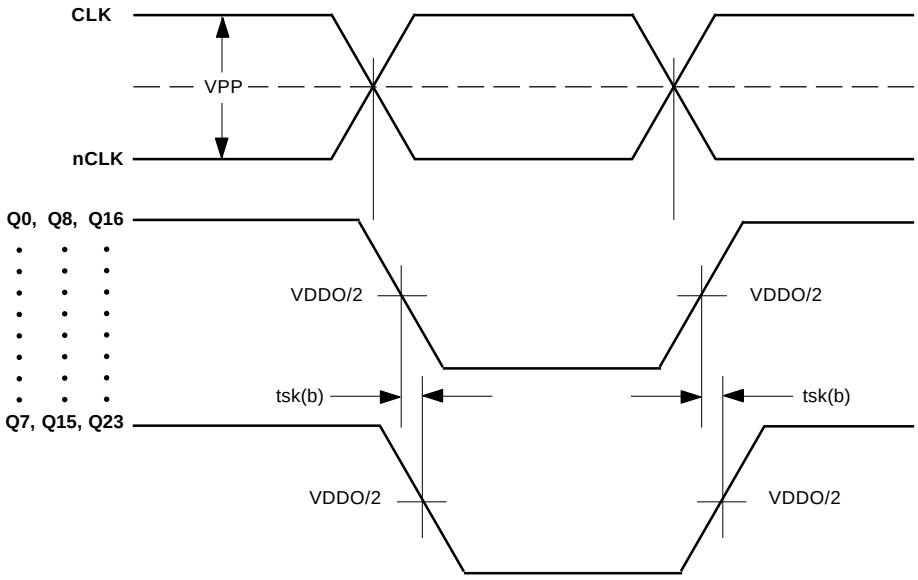


FIGURE 3A - BANK SKEW

fin = 167MHz, Vpp = 300mV, tr = tf = 200ps

Output Skew - Skew between outputs of any bank. Outputs operating at the same temperature, supply voltages and with equal load conditions.

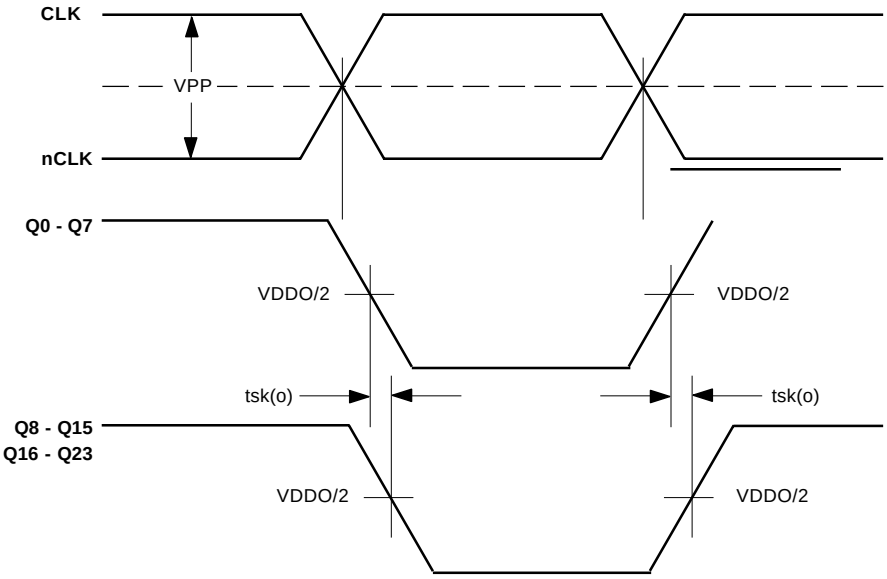


FIGURE 3B - OUTPUT SKEW

fin = 167MHz, Vpp = 300mV, tr = tf = 200ps

FIGURE 4A - SKEW DEFINITIONS & WAVEFORMS

Part to Part Skew - Skew between outputs of any bank on different parts. Outputs operating at the same temperature, supply voltages and with equal load conditions.

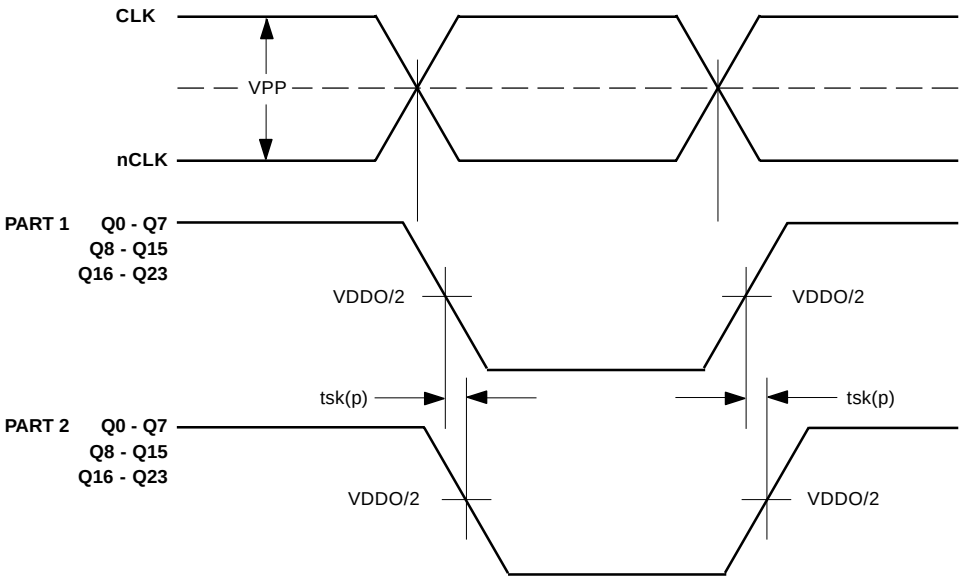


FIGURE 4B - OUTPUT SKEW

fin = 167MHz, Vpp = 300mV, tr = tf = 200ps

PACKAGE OUTLINE - Y SUFFIX

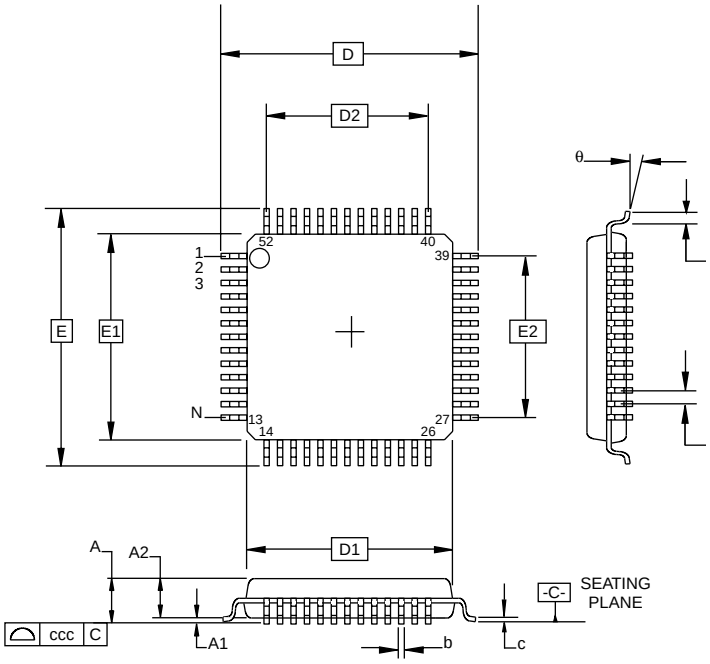


TABLE 6. PACKAGE DIMENSIONS

JEDEC VARIATION ALL DIMENSIONS IN MILLIMETERS			
SYMBOL	BCC		
	MINIMUM	NOMINAL	MAXIMUM
N		48	
A			1.60
A1	0.05		0.15
A2	1.35	1.40	1.45
b	0.17	0.22	0.27
c	0.09		0.20
D		9.00 BASIC	
D1		7.00 BASIC	
D2		5.50	
E		9.00 BASIC	
E1		7.00 BASIC	
E2		5.50	
e		0.5 BASIC	
L	0.45	0.60	0.75
θ	0°		7°
ccc			0.08

Reference Document: JEDEC Publication 95, MS-026

TABLE 7. ORDERING INFORMATION

Part/Order Number	Marking	Package	Count	Temperature
ICS8344BY	ICS8344BY	48 Lead LQFP	250 per tray	0°C to 70°C
ICS8344BYT	ICS8344BY	48 Lead LQFP on Tape and Reel	2000	0°C to 70°C